

IEEE TRANSACTIONS ON COMPONENTS, PACKAGING, AND MANUFACTURING TECHNOLOGY

A PUBLICATION OF THE COMPONENTS, PACKAGING, AND MANUFACTURING TECHNOLOGY SOCIETY



IEEE COMPONENTS, PACKAGING,
AND
MANUFACTURING TECHNOLOGY SOCIETY

WWW.CPMT.ORG

SEPTEMBER 2016
OCTOBER 2016

VOLUME 6
VOLUME 6

NUMBER 9
NUMBER 10

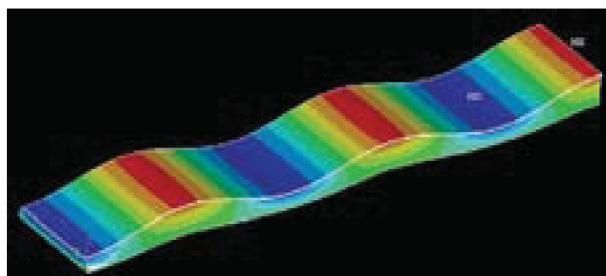
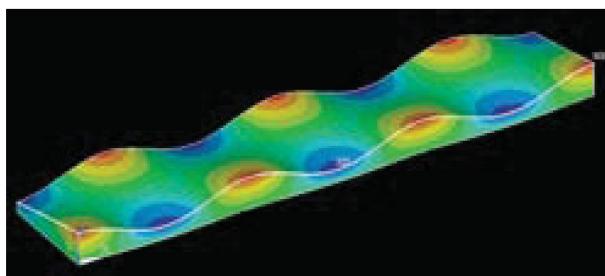
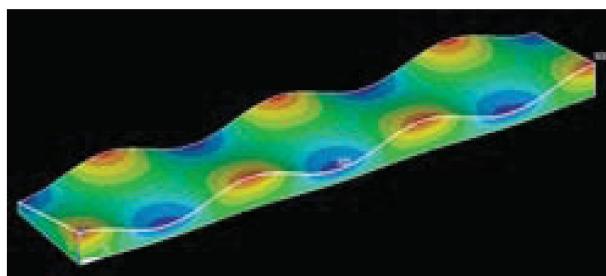
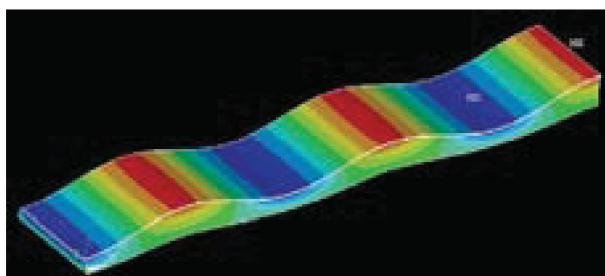
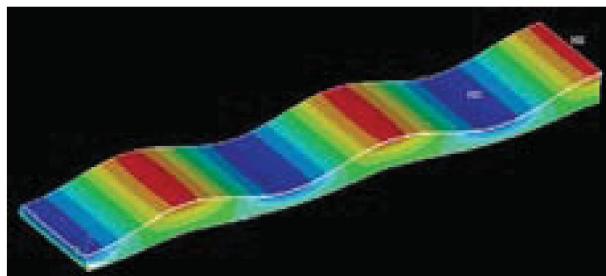
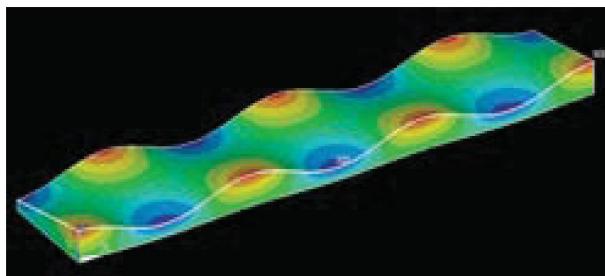
ITCPC8

(ISSN 2156-3950)

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Cover art from: “Fabrication and Modeling of Nitride Thin-Film Encapsulation Based on Anti-Adhesion-Assisted Transfer Technique and Nitride/BCB Bilayer Wrinkling,” by Seonho Seok (pp. 1301–1307, Fig. 3).



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